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Advanced Photon Counting Techniques XVI

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Contents

v *Conference Committee*

PHOTON COUNTING INSTRUMENTATION I

- 12089 02 **An 80MHz frame-rate 17.4% fill-factor 16×16 SPAD image array with event-based multiplexing for super-resolution microscopy** [12089-2]
- 12089 03 **A direct-detection LIDAR detector for the Europa lander concept (Invited Paper)** [12089-5]

QUANTUM APPLICATIONS OF SINGLE-PHOTON COUNTING I

- 12089 04 **Next-generation single photon sources for satellite-based quantum communication (Invited Paper)** [12089-8]

APPLICATIONS OF SINGLE-PHOTON COUNTING

- 12089 05 **Deep confocal fluorescence microscopy with single-photon superconducting nanowire detector (Invited Paper)** [12089-12]
- 12089 06 **Drone segmentation and orientation detection using a SPAD array camera** [12089-14]

QUANTUM APPLICATIONS OF SINGLE-PHOTON COUNTING II

- 12089 07 **Ultra-fast single-photon counting with waveguide-integrated detectors for quantum technologies (Invited Paper)** [12089-19]

SUPERCONDUCTING SINGLE-PHOTON DETECTORS

- 12089 08 **Superconducting nanowire single-photon detectors and detector arrays in the mid-infrared (Invited Paper)** [12089-20]

PHOTON COUNTING INSTRUMENTATION II

- 12089 09 **Event-driven SPAD camera with 60 ps IRF and up to $1.6 \cdot 10^8$ photon time-tagging measurements per second** [12089-25]
- 12089 0A **Deadtime-less single photon detection and potential applications** [12089-27]

SINGLE-PHOTON AVALANCHE DIODES

- 12089 0B **Low-noise high-dynamic-range single-photon avalanche diodes with integrated PQAR circuit in a standard 55nm BCD process (Invited Paper)** [12089-28]
- 12089 0C **Geiger-mode avalanche photodiode arrays fabricated on SOI engineered-substrates** [12089-29]
- 12089 0D **Performance optimization of InGaAs/InP SPADs for either low noise or high photon detection efficiency applications** [12089-10]
- 12089 0E **Mitigation of optical crosstalk in Geiger-mode avalanche photodiode arrays for lidar** [12089-11]
- 12089 0F **High-performances dual M-layers avalanche photodiodes from single-photon detection to high saturation output current (Invited Paper)** [12089-9]

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